TC22 SC37 WG3 Liaison Report for EVS-GTR

Thermal Propagation Work Item

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Introduction



- □ AAT & BJL participated in one TC22 SC37 WG3 meeting on Thermal Propagation since EVS 16th session:
 - 22-23 Oct-2018, Versailles, France
- 8 national standards organisations represented, plus one guest:
 - China (CN), France (FR), Germany (DE), Japan (JP), South Korea (KR), Sweden (SE), UK and USA
 - Canada (guest)
- ☐ Twin development themes continuing in parallel
 - Test method development
 - Multiple triggering concepts across various sponsors
 - Standardised methodology for "Documented Approach"
 - > SE lead

Note: Expectation that both concepts to be included in ISO 6469-1 amendment.





■ New definition proposals discussed:

- Internal Short Circuit ✓ (Definition agreed)
- Thermal Event- ✓ (Definition agreed)
- Thermal Runaway ✓ (Definition agreed)
- "Worst case" ISC (time/energy release) **★ (Agreed NOT to define due to complexity)**
- Internal [cell] failure * (Definition NOT agreed)

☐ Agreement to draft candidate test procedures by next meeting

- Various trigger method short-listed
 - ➤ Internal micro-heater (FR)
 - ➤ Internal Short Circuit Device (US)
 - ➤ Nail penetration (CN, DE & KR)

- ➤ Heater [conventional] (JP & KR)
- > Self-heating [resistor] (CN)
- > TRIM heater (SE)

- Further studies also agreed
 - Laser heating (JP)
 - Chemical heating [cell replacement] (DE)

☐ Draft standard/guideline for "documented approach"

• Being restructured by SE (AAT) for submission/circulation Jan-2019





- ☐ Most mature methods (plural) to be written in to ISO 6469-1 Amendment 1st Ed.
 - Promising but less mature methods to be considered up to DIS draft finalisation, circa Dec-2020
 - Target publication date Mar-2022
- ☐ Next steps
 - WD1 now to be drafted following next meeting
- **☐** Next meetings:
 - 5 to 7-Mar-2019, S. Korea
 - Autumn/Fall meeting dates tba, EU (likely DE in absence of further offers)